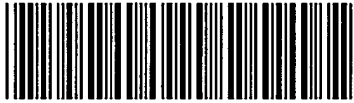


Search Notes

Application/Control No.

10/695,046

Applicant(s)/Patent under
ReexaminationPARSCHE, FRANCIS
EUGENE

Examiner

Shih-Chao Chen

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	700MS, 732, 767, 830, 866, 867	10/24/2005	CHEN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
343	700MS	10/24/2005	CHEN
343	732, 867	10/24/2005	CHEN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Search items: loop antenna, substrate, gap, slot, inner, outer diameter).	10/24/2005	CHEN